SDZS003A - OCTOBER 1989 - REVISED OCTOBER 1990

- 10KH Compatible
- ECL and TTL Control Inputs
- Noninverting Outputs
- Flow-Through Architecture Optimizes PCB Layout
- Center Pin V<sub>CC</sub>, V<sub>EE</sub>, and GND Configurations Minimize High-Speed Switching Noise
- Package Options Include "Small Outline" Packages and Standard Plastic 300-mil DIPs

### description

This octal ECL-to-TTL translator is designed to provide a efficient translation between a 10KH ECL signal environment and a TTL signal environment. This device is designed specifically to improve the performance and density of ECL-to-TTL CPU/bus-oriented functions such as memory-address drivers, clock drivers, and bus-oriented receivers and transmitters.

Two output-enable pins,  $\overline{OE}1$  and  $\overline{OE}2$ , are provided. These control inputs are ANDed together with  $\overline{OE}1$  being ECL compatible and  $\overline{OE}2$  being TTL compatible. This offers the choice of controlling the outputs of the device from either a TTL or ECL signal environment.

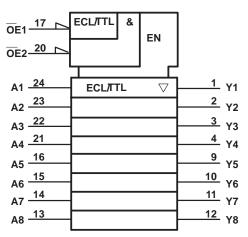
The SN10KHT5541 is characterized for operation from 0°C to 75°C.

#### **FUNCTION TABLE**

OUT	PUT	DATA	OUTPUT
ENABLE		INPUT	(TTL)
OE1	OE2	Α	Υ
Х	Н	Х	Z
Н	Х	Х	Z
L	L	L	L
L	L	Н	Н

#### DW OR NT PACKAGE (T0P VIEW) Υ1 **Γ** 24 A1 Y2 🕇 2 23 A2 Y3 **∏** 3 22 A3 Y4 **∏** 4 21 A4 20 OE2 (TTL) Vcc 🛮 5 GND [ 6 19 VEE 18 GND 7 GND **↑**8 17 OE1 (ECL) Y5 **∏** 9 16 A5 Y6 **1** 10 15 A6 Y7 **∏** 11 14 A7 Y8 **∏** 12 13 🗖 A8

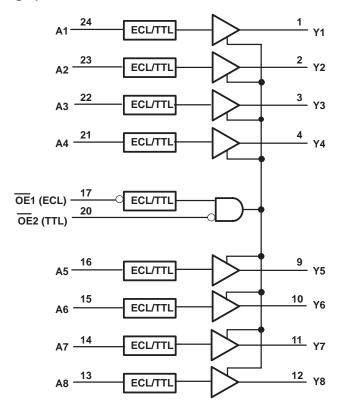
#### logic symbol†



<sup>&</sup>lt;sup>†</sup>This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



## logic diagram (positive logic)



SDZS003A - OCTOBER 1989 - REVISED OCTOBER 1990

#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V <sub>CC</sub>	$\dots$ $-0.5\ V$ to 7 $V$
Supply voltage, V <sub>EE</sub>	$\dots$ $-8\ V$ to 0 $V$
Input voltage (TTL) (see Note 1)	$\dots$ $-1.2\ V$ to 7 $V$
Input voltage (ECL)	$\ldots  V_{\text{EE}} \text{ to 0 V}$
Voltage applied to any output in the disabled or power-off state	. $$ –0.5 V to 5.5 V
Voltage applied to any output in the high state	$\dots$ -0.5 V to V <sub>CC</sub>
Input current (TTL)	-30 mA to 5 mA
Current into any output in the low state	96 mA
Operating free-air temperature range	$0^{\circ}$ C to $75^{\circ}$ C
Storage temperature range	-65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The TTL input voltage ratings may be exceeded provided the input current ratings are observed.

### recommended operating conditions

			MIN	NOM	MAX	UNIT
VCC	TTL supply voltage			5	5.5	V
VEE	ECL supply voltage			-5.2	-5.46	V
VIH	VIH TTL high-level input voltage					V
VIL	IL TTL low-level input voltage				0.8	V
	ECL high-level input voltage	T <sub>A</sub> = 0°C	-1170		-840	mV
V <sub>IH</sub> ‡		T <sub>A</sub> = 25°C	-1130		-810	
		T <sub>A</sub> = 75°C	-1070		-735	
	ECL low-level input voltage	T <sub>A</sub> = 0°C	-1950		-1480	mV
V <sub>IL</sub> ‡		T <sub>A</sub> = 25°C	-1950		-1480	
		T <sub>A</sub> = 75°C	-1950		-1450	
ΙΚ	TTL input clamp current				-18	mA
ГОН	High-level output current				-15	mA
lOL	Low-level output current				48	mA
T <sub>A</sub>	Operating free-air temperature				75	°C

<sup>‡</sup> The algebraic convention, in which the least positive (most negative) value is designated minimum, is used in this data sheet for logic levels only.



# SN10KHT5541 OCTAL ECL-TO-TTL TRANSLATOR WITH 3-STATE OUTPUTS

SDZS003A - OCTOBER 1989 - REVISED OCTOBER 1990

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER		TEST COND	ITIONS		MIN	TYP <sup>†</sup>	MAX	UNIT
VIK	OE2 only	$V_{CC} = 4.5 \text{ V},$	$V_{EE} = -4.94 \text{ V},$	I <sub>I</sub> = –18 mA				-1.2	V
Ц	OE2 only	$V_{CC} = 5.5 \text{ V},$	$V_{EE} = -5.46 \text{ V},$	V <sub>I</sub> = 7 V				0.1	mA
lн	OE2 only	$V_{CC} = 5.5 \text{ V},$	$V_{EE} = -5.46 \text{ V},$	V <sub>I</sub> = 2.7 V				20	μΑ
IIL	OE2 only	$V_{CC} = 5.5 \text{ V},$	$V_{EE} = -5.46 \text{ V},$	V <sub>I</sub> = 0.5 V				-0.5	mA
		$V_{CC} = 5.5 \text{ V},$	$V_{EE} = -5.46 \text{ V},$	$V_{I} = -840 \text{ mV}$	T <sub>A</sub> = 0°C			350	μА
۱н	Data inputs and OE1	$V_{CC} = 5.5 \text{ V},$	$V_{EE} = -5.46 \text{ V},$	$V_{I} = -810 \text{ mV}$	T <sub>A</sub> = 25°C			350	
		$V_{CC} = 5.5 \text{ V},$	$V_{EE} = -5.46 \text{ V},$	$V_{I} = -735 \text{ mV}$	T <sub>A</sub> = 75°C			350	
	Data inputs and OE1	V <sub>CC</sub> = 5.5 V,	V <sub>EE</sub> = -5.46 V,	V <sub>I</sub> = -1950 mV	$T_A = 0$ °C	0.5			
IJL					T <sub>A</sub> = 25°C	0.5			μΑ
					T <sub>A</sub> = 75°C	0.5			
Vou		$V_{CC} = 4.5 \text{ V},$	$V_{EE} = -5.2 \text{ V} \pm 5\%,$	$I_{OH} = -3 \text{ mA}$		2.4	3.3		V
VOH		$V_{CC} = 4.5 \text{ V},$	$V_{EE} = -5.2 \text{ V} \pm 5\%,$	$I_{OH} = -15 \text{ mA}$		2	3.1		٧
VOL		$V_{CC} = 4.5 \text{ V},$	$V_{EE} = -5.2 \text{ V} \pm 5\%,$	$I_{OL} = 48 \text{ mA}$			0.38	0.55	V
lozh			$V_{EE} = -5.46 \text{ V},$	$V_0 = 2.7 \text{ V}$				50	μΑ
lozL			$V_{EE} = -5.46 \text{ V},$	$V_0 = 0.5 V$				-50	μΑ
los‡			$V_{EE} = -5.46 \text{ V},$	VO = 0		-100		-225	mA
ICCH		$V_{CC} = 5.5 \text{ V},$	$V_{EE} = -5.46 \text{ V}$				64	97	mA
ICCL		$V_{CC} = 5.5 \text{ V},$	$V_{EE} = -5.46 \text{ V}$				80	120	mA
ICCZ		$V_{CC} = 5.5 V$ ,	$V_{EE} = -5.46 \text{ V}$				77	116	mA
IEE		$V_{CC} = 5.5 \text{ V},$	$V_{EE} = -5.46 \text{ V}$	·			-22	-33	mA
Ci	·	$V_{CC} = 5 V$ ,	$V_{EE} = -5.2 \text{ V}$				5		pF
Co		$V_{CC} = 5 V$ ,	$V_{EE} = -5.2 \text{ V}$				7		pF

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $V_{EE} = -5.2 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

# switching characteristics over recommended ranges of operating free-air temperature and supply voltage (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$C_L$ = 50 pF, R1 = 500 Ω, R2 = 500 Ω		2,	UNIT
			MIN	TYP§	MAX	
<sup>t</sup> PLH	A	V	1.7	4	6.2	
<sup>t</sup> PHL		T T	1.6	4	6.2	ns
<sup>t</sup> PZH	ŌĒ1	Υ	2.6	4.7	6.7	
<sup>t</sup> PZL		Y	3.2	5.9	8.5	ns
<sup>t</sup> PHZ	ŌE1	Y	2.9	5.4	7.8	ns
<sup>t</sup> PLZ		'	1.9	4.9	7.8	''3
<sup>t</sup> PZH	OE2	V	1.7	4	6.2	ns
<sup>t</sup> PZL	JE2	1	2.5	5.1	7.7	115
<sup>t</sup> PHZ	<del>OE</del> 2	· ·	2.1	4.3	6.4	
<sup>t</sup> PLZ		Y	1.1	3.7	6.3	ns

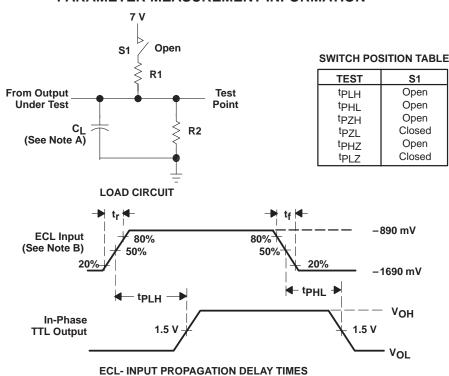
<sup>§</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $V_{EE} = -5.2 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

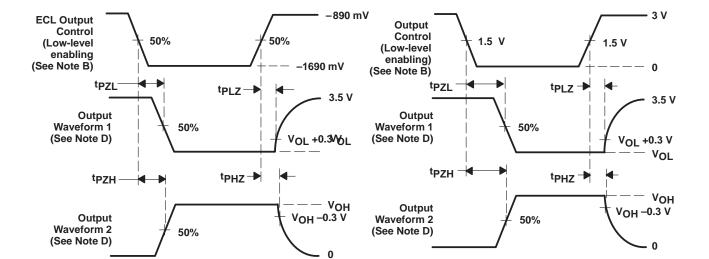


<sup>‡</sup> Not more than one output should be tested at a time and the duration of the test should not exceed 10 ms.

TTL ENABLE AND DISABLE TIMES

#### PARAMETER MEASUREMENT INFORMATION





NOTES: A.  $C_L$  includes probe and jig capacitance.

- B. For TTL inputs, input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_0$  = 50  $\Omega$ ,  $t_f \leq$  2.5 ns.  $t_f \leq$  2.5 ns.
- C. For ECL inputs, input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_0 = 50 \Omega$ ,  $t_f \leq$  0.7 ns,  $t_f \leq$  0.7 ns.
- D. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- E. The outputs are measured one at a time with one transition per measurement.

**ECL ENABLE AND DISABLE TIMES** 

### FIGURE 1. LOAD CIRCUIT AND VOLTAGE WAVEFORMS



#### **IMPORTANT NOTICE**

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.

Copyright © 1998, Texas Instruments Incorporated